

Application No.	Applicant(s)	
10/602,245	CHAN ET AL.	
Examiner	Art Unit	
Jan Mooneyham	3629	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH S)
	DATE	EXMR
inventor and continuity search	1/9/2005	ML
East text search- US Pat, US Pat Pub, EPO, JPO, Derwent	1/9/2005	JM
ProQuest	1/10/2005	JM